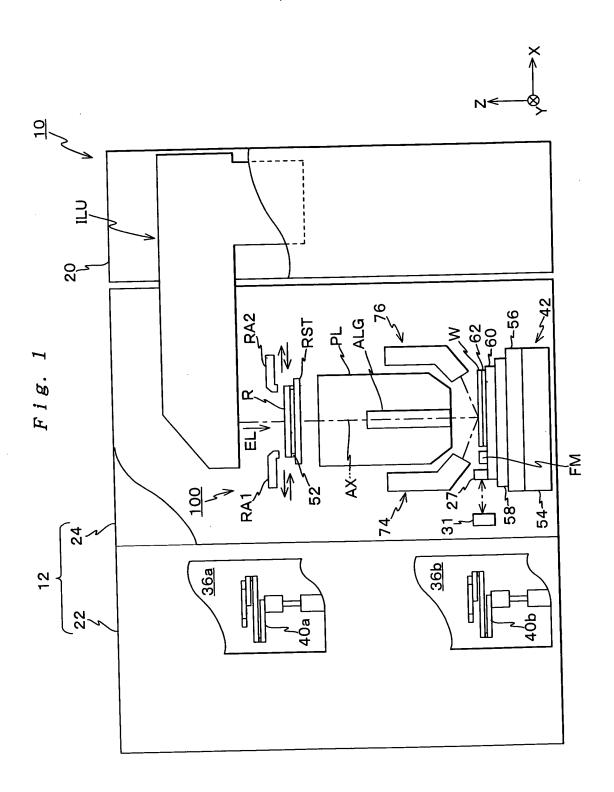
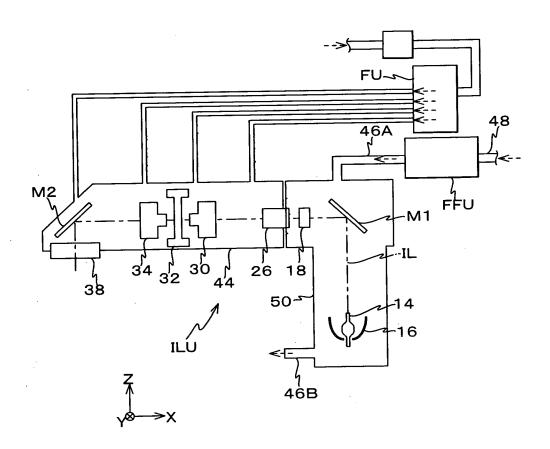
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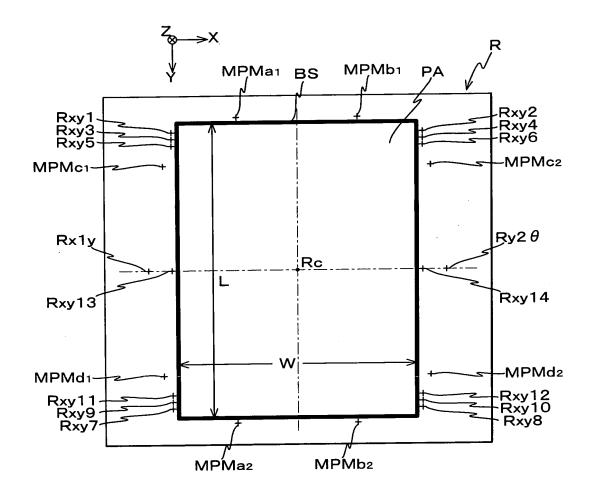
Fig. 2



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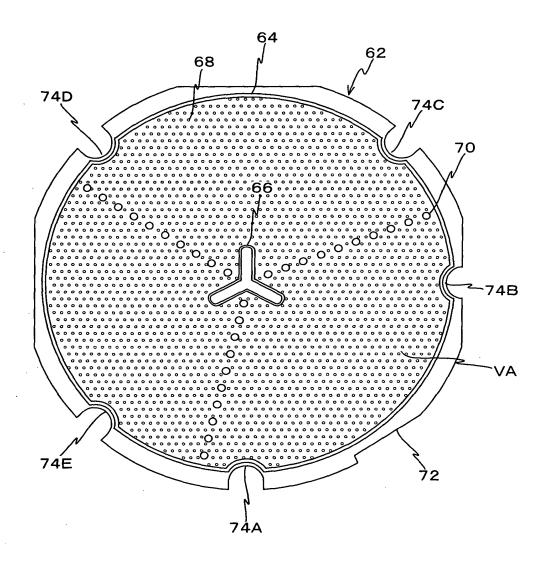
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Fig. 3



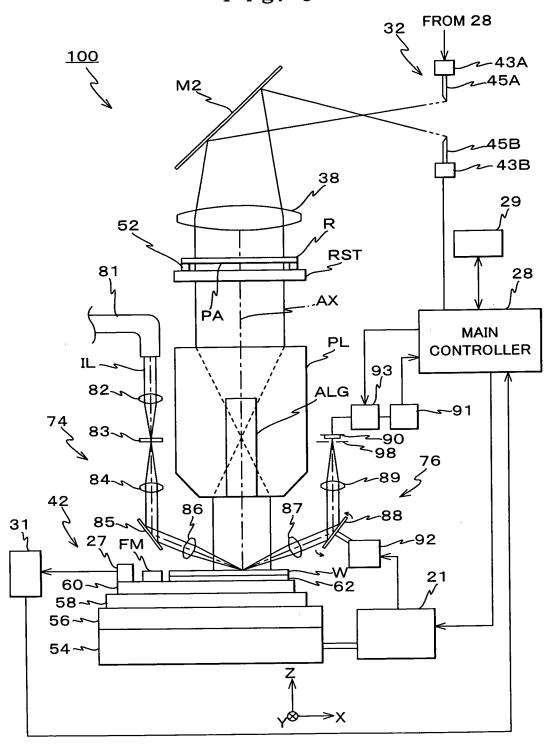
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Fig. 4

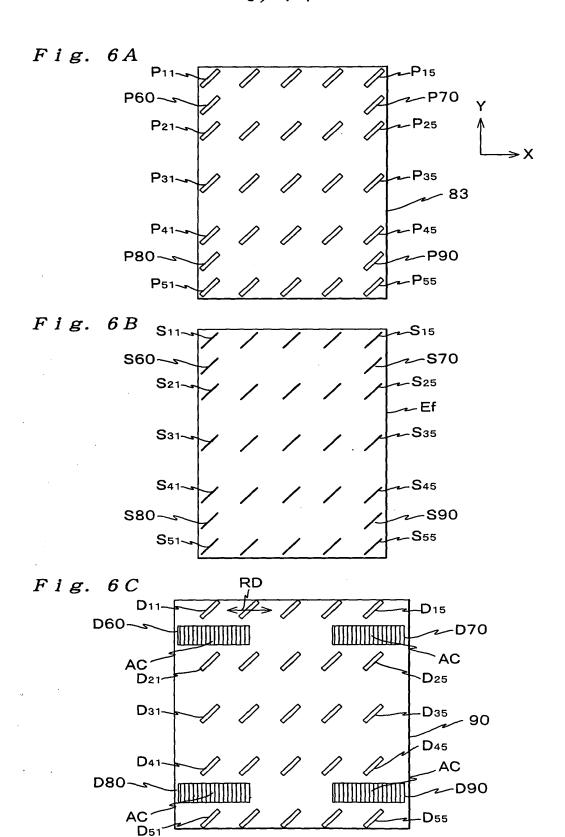


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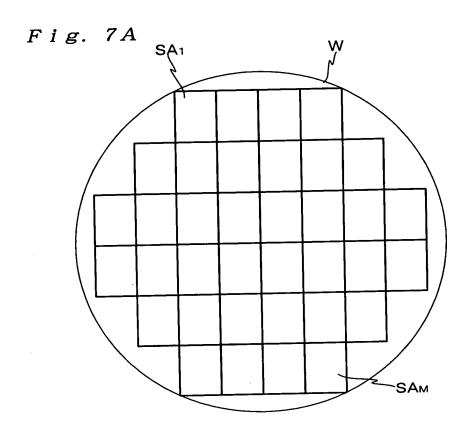
Fig. 5

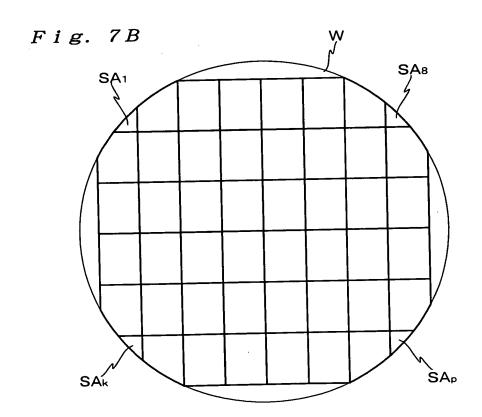


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Fig. 8A

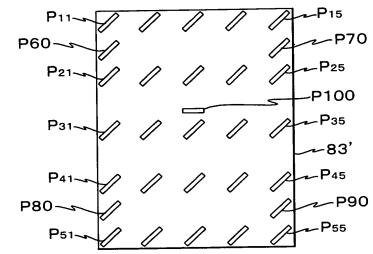


Fig. 8B

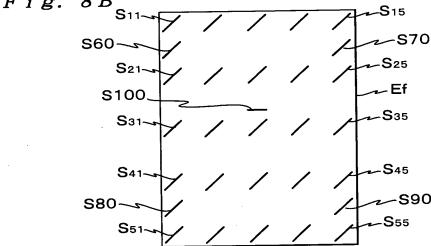
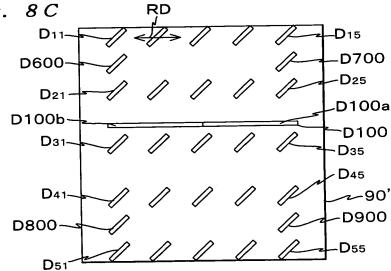
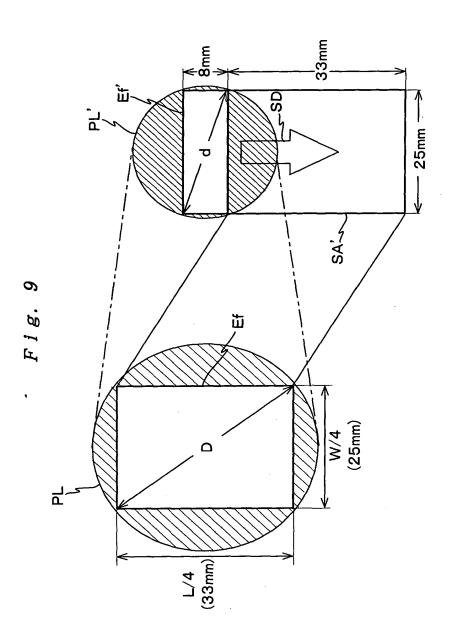


Fig.

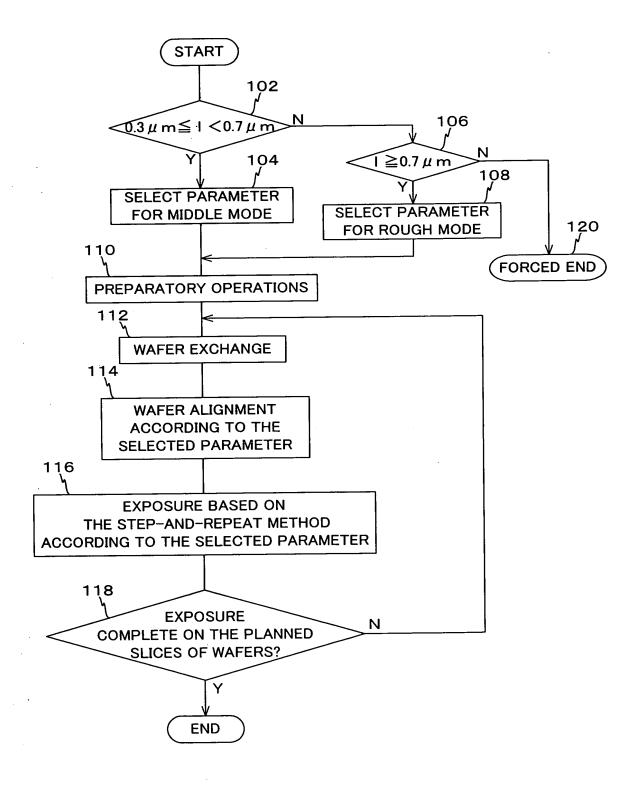


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Fig. 10



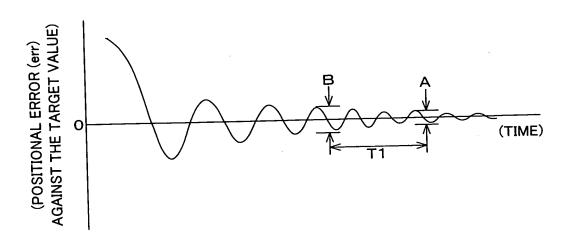
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Fig. 11

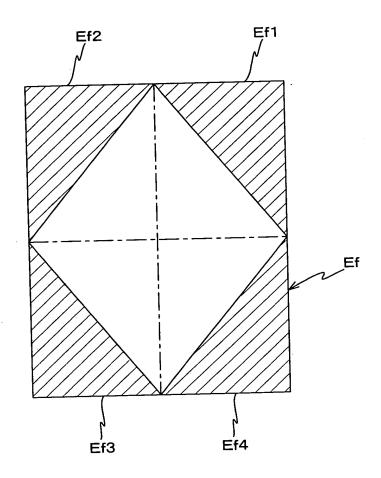
MINIMUM LINE WIDTH SUBJECT TO EXPOSURE I	0. 3 μ m≦ l <0. 7 μ m	0. 7 µ m≦ l
X, Y PERMISSIBLE VALUES	±0. 1μm	±1μm
Z PERMISSIBLE VALUE	±0. 1μm	±1 µ m
NUMBER OF SCREENS FOR ALIGNMENT MEASUREMENT	5	1
NUMBER OF SAMPLE SHOTS	12	3

Fig. 12



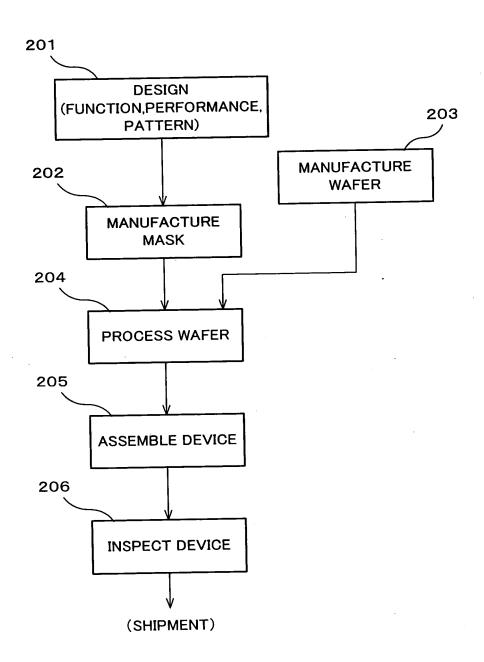
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Fig. 13



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Fig. 14



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Fig. 15

